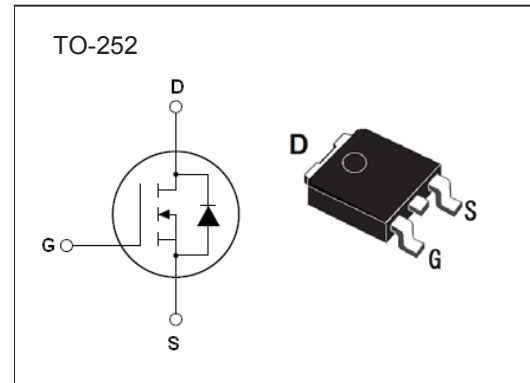


N-Channel MOSFET

2KK5067

■ Features

- $BV_{DSS} = 650\text{ V}$
- $I_D = 11.5\text{ A}$
- $R_{DS(ON)} = 290\text{ m}\Omega(\text{Typ.}) @ V_{GS} = 10\text{ V}$
- New technology for high voltage device
- Low on-resistance and low conduction losses
- Small package
- Ultra Low Gate Charge cause lower driving requirements
- 100% Avalanche Tested

■ Absolute Maximum Ratings($T_C=25^\circ\text{C}$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	± 30	
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	A
		$T_C=100^\circ\text{C}$	
Pulsed Drain Current (Note 1)	I_{DM}	46	
Single Pulse Avalanche Energy (Note 2)	EAS	144	mJ
Repetitive Avalanche Energy , t_{AR} limited by T_{jmax} (Note 1)	EAR	0.5	
Avalanche Current (Note 1)	I_{AR}	6	A
Drain Source Voltage Slope, $V_{DS} \leq 480\text{ V}$	dv/dt	50	V/ns
Reverse Diode dv/dt , $V_{DS} \leq 480\text{ V}, I_{SD} < I_D$	dv/dt	15	
Power Dissipation	P_D	101	W
Thermal Resistance. Junction- to-Case	$R_{\theta JC}$	1.24	$^\circ\text{C}/\text{W}$
Thermal Resistance. Junction- to-Ambient	$R_{\theta JA}$	62	
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 to 150	

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. EAS condition: $T_J=25^\circ\text{C}, V_{DD}=50\text{ V}, V_G=10\text{ V}, R_G=25\Omega$

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■ Electrical Characteristics (T_c = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	I _D = 250 μA, V _{GS} = 0V	650			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 650 V, V _{GS} = 0 V			1	μA
		V _{DS} = 650 V, V _{GS} = 0 V, T _c = 125°C			100	
Gate to Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±30 V			±100	nA
Gate to Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	3		4	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 7 A		290	360	mΩ
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 50 V, f = 1 MHz		870		pF
Output Capacitance	C _{oss}			54		
Reverse Transfer Capacitance	C _{rss}			1.8		
Total Gate Charge	Q _g	V _{GS} = 10V, V _{DS} = 480 V, I _D = 11.5 A		19		nC
Gate Source Charge	Q _{gs}			6		
Gate Drain Charge	Q _{gd}			6.5		
Turn-On Delay Time	t _{d(on)}	V _{DD} =380V, I _D =5.8A, R _G =3Ω, V _{GS} =10V		11		ns
Turn-On Rise Time	t _r			8		
Turn-Off Delay Time	t _{d(off)}			58	70	
Turn-Off Fall Time	t _f			9	14	
Source-drain current(Body Diode)	I _{SD}				11.5	A
Pulsed Source-drain current(Body Diode)	I _{SDM}				46	
Diode Forward Voltage	V _{SD}	T _j =25°C, I _{SD} =11.5A, V _{GS} =0V		0.9	1.2	V
Reverse Recovery Time	t _{rr}	T _j =25°C, I _F =5.8A, di/dt=100A/μs		220		ns
Reverse Recovery Charge	Q _{rr}			2.2		μC
Peak Reverse Recovery Current	I _{rm}			19		A

■ Marking

Marking	K5067
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■ Typical Electrical and Thermal Characteristics

Figure 1. Safe operating area

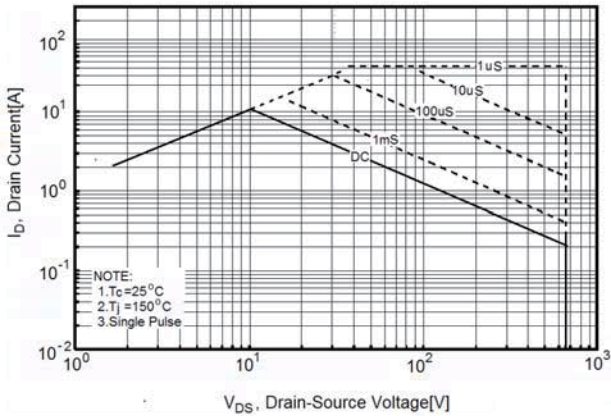


Figure 2. Transient Thermal Impedance

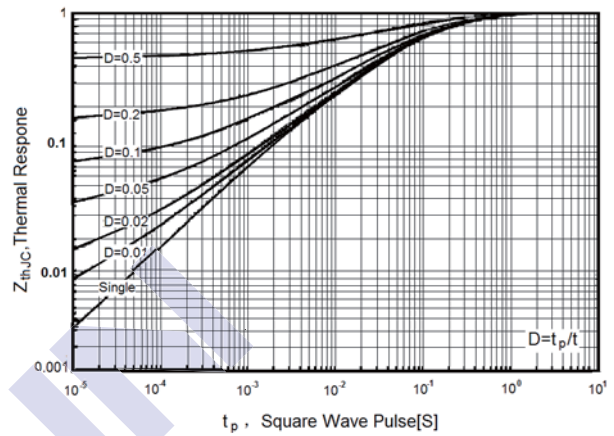


Figure 3. Source -Drain Diode Forward Voltage

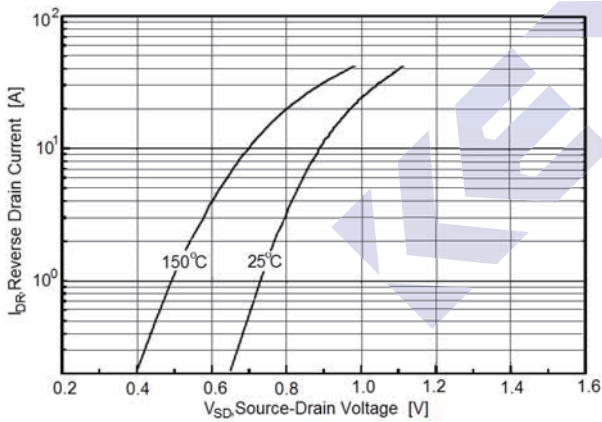


Figure 4. Output characteristics

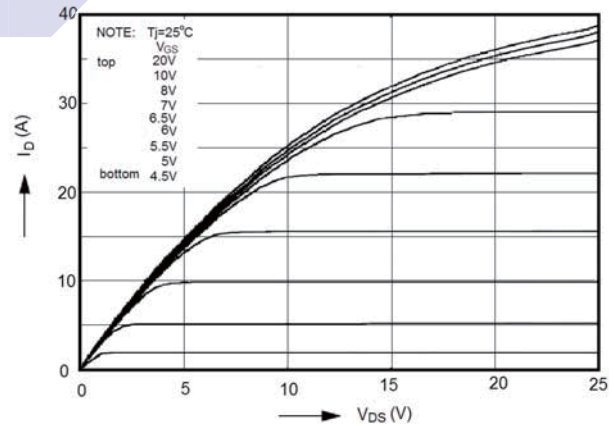


Figure 5. Transfer characteristics

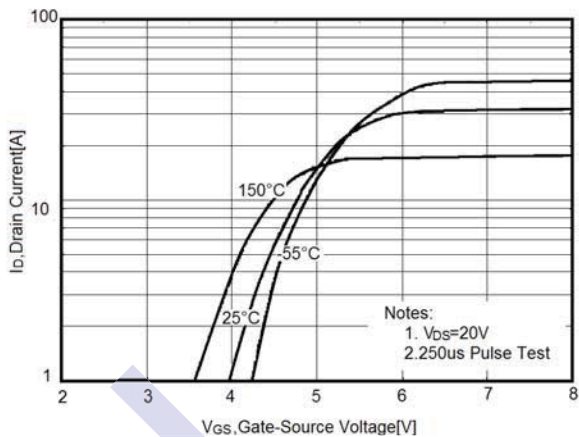
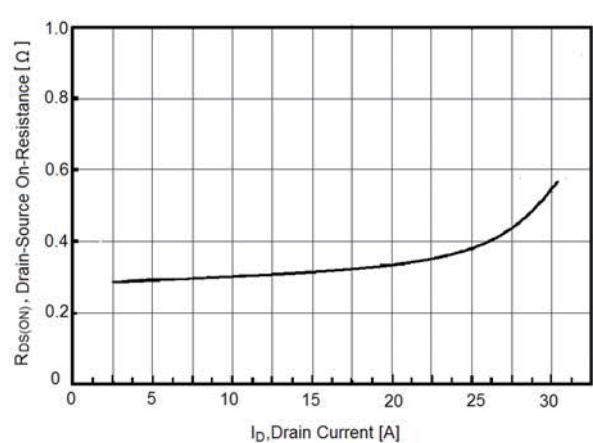


Figure 6. Static drain -source on resistance



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Figure 7. $R_{DS(ON)}$ vs Junction Temperature

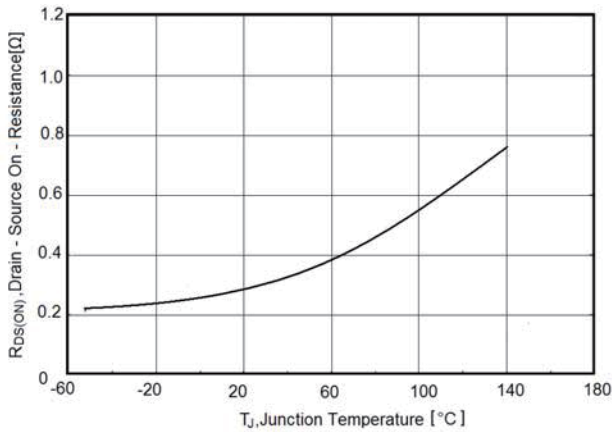


Figure 8. BV_{DSS} vs Junction Temperature

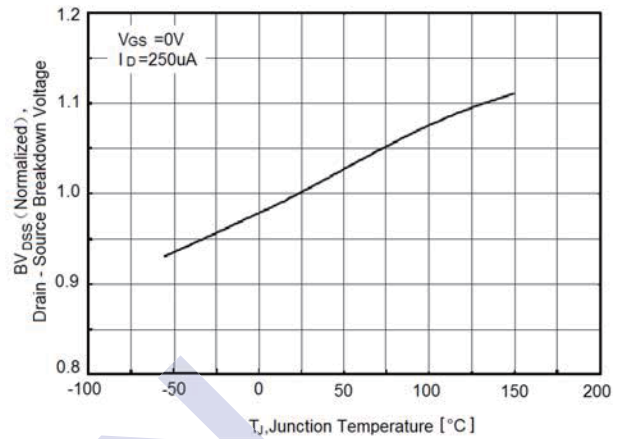


Figure 9. Maximum I_D vs Junction Temperature

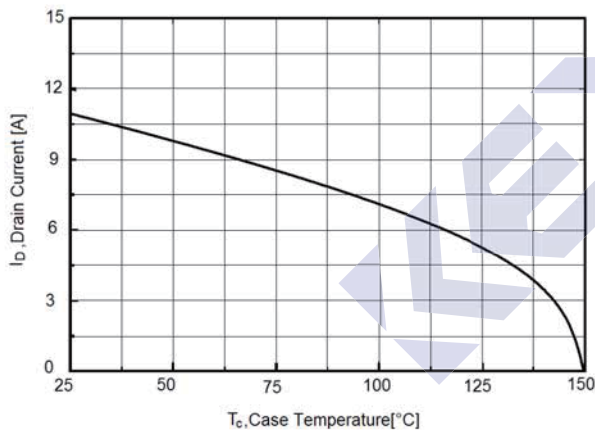


Figure 10. Gate charge waveforms

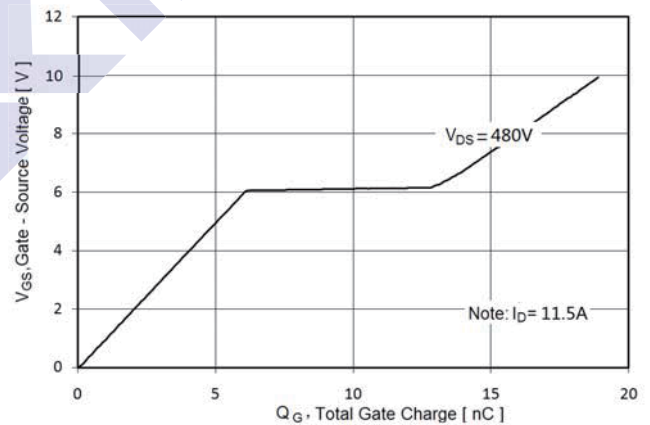
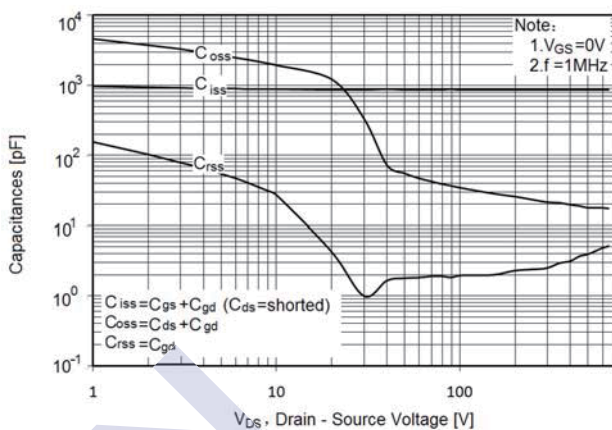


Figure 11. Capacitance

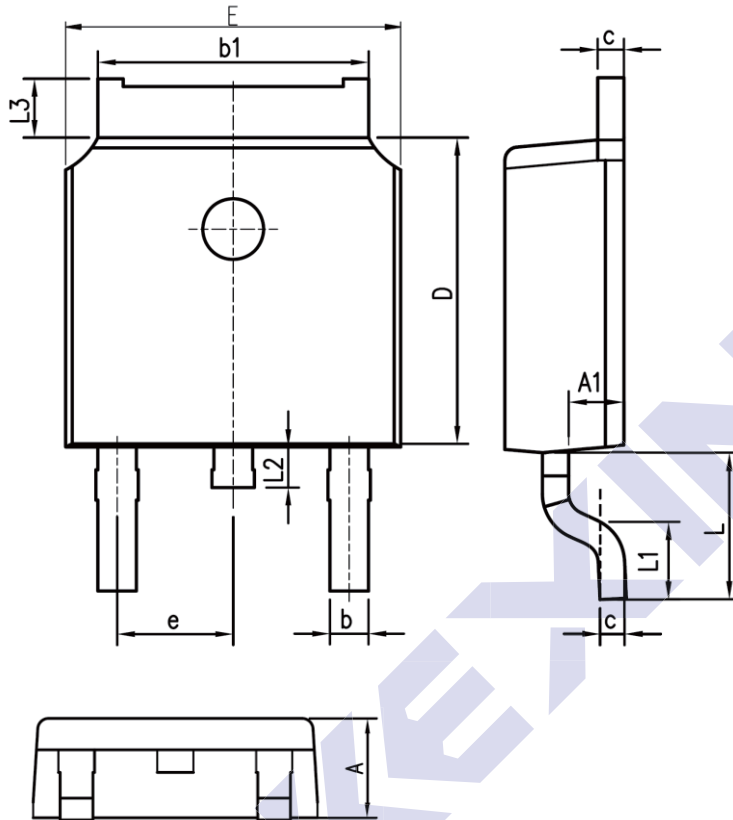


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■ Package Outline Dimensions

Unit:mm



SYMBOL	mm	
	MIN	MAX
A	2.10	2.50
A1	0.97	1.17
b	0.63	0.93
b1	5.13	5.53
c	0.40	0.60
D	5.80	6.40
E	6.30	6.90
e	2.286BSC	
L	2.50	3.30
L1	1.20	1.80
L2	0.60	1.00
L3	0.85	1.30